

Notice of References Cited

Application/Control No.

09/550,878

Applicant(s)/Patent Under Reexam

Heiden, Richard W. et al.

Examiner

Pierre E. Elisca

Art Unit

3621

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U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
A	6,321,210	11/2001	O'Brien et al.	705	14
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FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
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U.S. PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
*	A	6,321,210	11/2001	O'Brien et al.	705	14
*	B	6,154,733	11/2000	Pierce et al.	705	408
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
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FOREIGN PATENT DOCUMENTS

		Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
*	N	JP410258844A	9/1998	JP	Yamada, Kuniyuki	----	----
	O						
	P						
	Q						
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	T						

NON-PATENT DOCUMENTS

		Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
*	U	Derwent = ACC-NO: 2000-629491; Heiden, R. W. et al.
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